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# Three Dimentional Capacitor as Function of Voltage of Metal-Insulator-Electrolyte (MIE) and concentration of Electrolyte Plot for Ideal Case of MIE

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### ABSTRACT

The total capacitance of the metal-insulator-electrolyte(MIE) has been studied theoretically.Mathematical model of the capacitance for MIE has been developed for ideal case.In the ideal case , a totally blocked interface has been assumed , such that the MIE behavior is governed only by electrostatic factors.Three dimensional plots for capacitance as a function of ,  $V_{\rm G}$ , the potential between metal and electrolyte and the concentration of electrolyte is presented for the first time.

Key words: Double layer, Capacitance of metal-Insulator- Electrolyte.

#### INTRODUCTION

Studies of the capacitance of the double layer was done for the first time by Graham<sup>1</sup>. Ofcourse these studies are focused on metalelectrolyte structure. In previous work <sup>2–6</sup> Metal-Insulator-Electrolyte structure were studied by us. It is common to study the interface of insulatorsemiconductor in metal-insulator-semiconductor structure to use capacitance voltage plot <sup>7</sup>.

In present work we obtain the expression for capacitance of metal-insulator-electrolyte(MIE) structure , we plot the capacitance as a function of,  $V_{G}$ , voltage between metal and electrolyte and ,

 $n^{o}$ , the concentration of electrolyte in three dimension. The ideal system of MIE is studied.

#### Ideal MIE structure

The ideal MIE system is similar to what Siu<sup>8</sup> etal. have defined as the totally blocked interface of an insulator/electrolyte part of a semiconductor-insulator structure. In ideal MIE, there is a complete absence of interfacial reactions between the electrolyte and the oxide. Since the interfacial electrochemical processes are absent, the charge and potential distribution in this MIE system is dictated solely by electrostatic consideration. Furthermore, because the oxide exhibits no specificity to ionic species in the electrolyte the response is determined by the total ionic strength , i.e. , the combined effects of all the ions in the electrolyte.

 $V_{o}$  is the potential applied between metal and electrolyte. The charge per unit area and the potential in the electrolyte space charge region are related by the Poisson-Boltzman equation.

From Gauss's law and solution to this equation, we find that for an electrolyte the charge per unit area in the Gouy-Chapman space- charge region is given by

$$\sigma_d = (8\varepsilon_e kTn^o)^{1/2} \sinh[q(V_G - \Psi_d)/2kT]$$
...(1)

To find the capacitance-voltage and concentration of electrolyte of the ideal MIE system since  $C_{d}$  the diffuse layer capacitance  $C_{H}$  the capacitance of the Helmholtz and  $C_{o}$  the capacitance of the oxide are in series , we have ,

$$C'_{o} = \frac{C_{H} \cdot C_{o}}{C_{o} + C_{H}} \text{ since } C_{H} \gg C_{o}, \text{ then } C'_{o} \approx C_{o} \qquad \dots (2)$$

where  $\ C_o$  is the oxide layer capacitance ,

 $C_H$  is the inner Helmholtz layer capacitance and is  $C_d$  the diffuse layer capacitance. We can find C<sub>d</sub> by taking the derivative of equation (1), as

$$C_d = -\frac{\partial \sigma_d}{\partial \Psi_d} = \left(\frac{2\varepsilon_e n^e q^2}{kT}\right)^{1/2} \cosh\left[\frac{q(\Psi_d - V_G)}{2kT}\right] \qquad \dots (4)$$

where  $\epsilon_{\rm e}$  is the dectvic constant of electrolyte, q is the electronic charge, k is the Boltzman constant T is the temperature and  $\Psi_{\rm d}$  is the potential at the outer Helmholtz layer and  $V_{\rm g}$  is the potential between metal and electrolyte. Substituting equation (4) into (3), we get

$$C_T = \frac{C_o (\frac{2\varepsilon_e n^o q^2}{kT})^{1/2} \cosh[\frac{q(\Psi_d - V_G)}{2kT}]}{C_o + (\frac{2\varepsilon_e n^o q^2}{kT}) \cosh[\frac{q(\Psi_d - V_G)}{2kT}]} \dots (5)$$

The difference  $(\Psi_d - V_G)$  is the zeta potential, so by inserting the equation obtained in previous work<sup>6</sup> for zeta potential equation (6) in to equation (5)

...(6)

we find  $C_T$  with respect to  $V_G$ .

$$C_{T} = \frac{-2\frac{kT}{q}C_{o}(\frac{2\varepsilon_{e}n^{o}q^{2}}{kT})^{1/2}\cosh\sinh^{-1}[\frac{V_{G}C_{o}}{(8\varepsilon_{e}kTn^{o})^{1/2}}]}{C_{o}-\frac{2kT}{q}(\frac{2\varepsilon_{e}n^{o}q^{2}}{kT})^{1/2}\cosh\sinh^{-1}[\frac{q(\Psi_{d}-V_{G})}{2kT}]}\dots(7)$$

By using equation (8)

...(3)

$$\overset{C_{T}}{O}_{T} = \frac{2\mathcal{K}_{T}^{T}C_{o}^{'}}{C_{g}} \overset{L_{o}^{*}}{\underset{o}{\text{simple}}} \overset{L_{o}^{*}}{x} \left[ \frac{V_{G}C_{o}}{(8\mathcal{E}_{o}^{*}KTn^{'}x^{'}+(x^{'}x^{'}+1)^{1/2}} \right] \quad \dots (8)$$



Fig.1:Three dimentional plot of total capacitance of MIE, , as a function of  $V_G$  and ,  $n^o$ , the electrolyte concentration

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and the definition of  $\cosh x = (e^x + e^{-x})/2$  by simple algebraic manipulation we find,

$$\cosh(\sinh^{-1} x) = x + \frac{1}{x + (x^2 + 1)^{1/2}}$$
 ...(9)

applying identity (9) to equation (7), it can be converted to

 $C_{T} = \frac{-2\alpha_{i}^{2}\alpha_{2}^{2}C_{o}^{2}V_{G}^{2} - 2\alpha_{i}^{2}\alpha_{2}^{2}C_{o}^{2}V_{G}[(\alpha_{2}V_{G}C_{o})^{1/2} + 1] - 2\alpha_{i}^{2}\alpha_{2}C_{o}}{C_{o}^{2}\alpha_{2}V_{G} + C_{o}[(\alpha_{2}V_{G}C_{o})^{2} + 1]^{1/2} - 2\alpha_{i}^{2}\alpha_{2}^{2}C_{o}^{2}V_{G}^{2} - 2\alpha_{i}^{2}\alpha_{2}^{2}C_{o}V_{G}[(\alpha_{2}V_{G}C_{o})^{2} + 1]^{1/2} - 2\alpha_{i}^{2}\alpha_{2}}$ ...(10)

where

$$\alpha_1 = \left(\frac{2\varepsilon_e n^o q^2}{kT}\right)^{1/2}$$
$$\alpha_2 = \frac{1}{\left(8\varepsilon_e kT n^o\right)^{1/2}}$$

$$\alpha_1 \alpha_2 = \frac{q}{2kT}$$

 $C_T$  has been plotted three dimentionally as a function of  $V_G$  and  $n^o$  concentration of electrolyte in fig.1 by Maple 10 software for the first time. There a beautiful symmetrical groove shape is demonstrated. The range of  $V_G$  is between -200 volt to 200 volt and  $n^o$  is between 0.001 M to 0.01 M varies.

## CONCLUSION

There are two parameters which vary as a function of the V<sub>G</sub> voltage between metal and electrolyte in metal-insulator-electrolyte (MIE) structure and  $n^o$  the concentration of electrolyte.

These two parameters are one zeta potential, the potential in the diffuse layer and the total capacitance of MIE structure. In reference 6 the zeta potential was plotted as a function of V<sub>g</sub> and  $n^o$  three dimensionally for the first time for the ideal case where theres is only electrostatic forces are present and surface ionization of the insulator is absent. In present work C<sub>T</sub> the total capacitance of MIE has been plotted as a function of V<sub>g</sub> and  $n^o$ 

in three dimension . A very nice symmetrical groove shape three dimensional surface results.

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